Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination HORIGOME, HIDEO	
10/758,074		
Examiner	Art Unit	
Yalkew Fantu	2838	

SEARCHED				
Class	Subclass	Date	Examiner	
320	132,107	6/1/2007	YF	
340	636.1	6/1/2007	YF	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
DATE	EXMR		
6/1/2007	YF		
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	DATE 6/1/2007		